Se	arch No	tes	

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/603,813	LEE ET AL.	
Examiner	Art Unit	
Jorge L. Ortiz-Criado	2627	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NO (INCLUDING SEARCH	TES STRATEGY)
	DATE	EXMR
update search, east, see printout	6/15/2007	JOC